杰力科技股份有限公司
Excelliance MOS Corporation

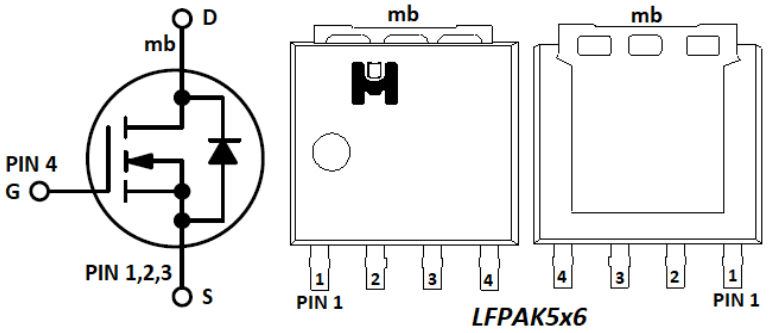
EMP05L03RHCS

Single N-Channel Logic Level Enhancement Mode Field Effect Transistor

▪Product Summary:

	N-CH
BV_{DSS}	30V
$R_{DSON\ (MAX.)}$@V_{GS}=10V	0.58mΩ
I_D @T_C=25°C	467A
I_D @T_A=25°C	53A

▪ Pin Description:



Single N Channel MOSFET
UIS, Rg 100% Tested
RoHS & Halogen Free & TSCA Compliant

▪ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current[1]	T_C = 25 °C	I_D	467	A
	T_C = 100 °C		295	
Continuous Drain Current[1]	T_A = 25 °C	I_D	53	
	T_A = 70 °C		42	
Pulsed Drain Current[1]		I_{DM}	1550	
Avalanche Current[1,4]		I_{AS}	141	
Avalanche Energy[1,4]	L = 0.1mH	EAS	994	mJ
Repetitive Avalanche Energy[2,4]	L = 0.05mH	EAR	497	
Power Dissipation[1]	T_C = 25 °C	P_D	208	W
	T_C = 100 °C		83	
Power Dissipation[1]	T_A = 25 °C	P_D	2.7	W
	T_A = 70 °C		1.7	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

▪ 100% UIS testing in condition of VD=25V, L=0.1mH, VG=10V, IL= 85A,RG=25Ω,Rated VDS=30V N-CH

▪THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case		$R_{\theta JC}$		0.6	°C/W
Junction-to-Ambient[3]	t≦10s	$R_{\theta JA}$		15	
	Steady-State	$R_{\theta JA}$		46	

[1]Pulse width limited by maximum junction temperature.

[2]Duty cycle < 1%

[3]The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

[4]Guarantee by Engineering test

▪ ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage[4]	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250μA	30			V
Gate Threshold Voltage[4]	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	1.2	1.8	2.5	V
Gate-Body Leakage[4]	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current[4]	I_{DSS}	V_{DS} = 30V, V_{GS} = 0V			1	μA
		V_{DS} =30V, V_{GS} =0V, T_J = 125 °C			25	
On-State Drain Current[1]	$I_{D(ON)}$	V_{DS} = 10V, V_{GS} = 10V	467			A
Drain-Source On-State Resistance[1,4]	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 30A		0.45	0.58	mΩ
Forward Transconductance[1]	g_{fs}	V_{DS} = 3V, I_D = 30A		77		S
DYNAMIC						
Input Capacitance[5]	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1MHz		9330		pF
Output Capacitance[5]	C_{oss}			4350		
Reverse Transfer Capacitance[5]	C_{rss}			100		
Gate Resistance[4,5]	R_g	f = 1MHz		0.9		Ω
Total Gate Charge[1,2,5]	Q_g(V_{GS}=10V)	V_{DS} = 15V, V_{GS} = 10V, I_D = 30A		140		nC
	Q_g(V_{GS}=4.5V)			65		
Gate-Source Charge[1,2,5]	Q_{gs}			35		
Gate-Drain Charge[1,2,5]	Q_{gd}			20		
Turn-On Delay Time[1,2,5]	$t_{d(on)}$	V_{DS} = 15V, V_{GS} = 10V, I_D = 5A , Rg = 3Ω		16		nS
Rise Time[1,2,5]	t_r			17		
Turn-Off Delay Time[1,2,5]	$t_{d(off)}$			85		
Fall Time[1,2,5]	t_f			50		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				174	A
Pulsed Current[3]	I_{SM}				1550	
Forward Voltage[1,4]	V_{SD}	I_F = 30A, V_{GS} = 0V			1.2	V
Reverse Recovery Time[5]	t_{rr}	I_F =30A, dI_F/dt = 100A / μS		70		nS
Peak Reverse Recovery Current[5]	$I_{RM(REC)}$			2.5		A
Reverse Recovery Charge[5]	Q_{rr}			100		nC

[1]Pulse test : Pulse Width ≦ 300 usec, Duty Cycle ≦ 2%.

[2]Independent of operating temperature.

[3]Pulse width limited by maximum junction temperature.

[4]Guarantee by FT test Item

[5]Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.

▪TYPICAL CHARACTERISTICS

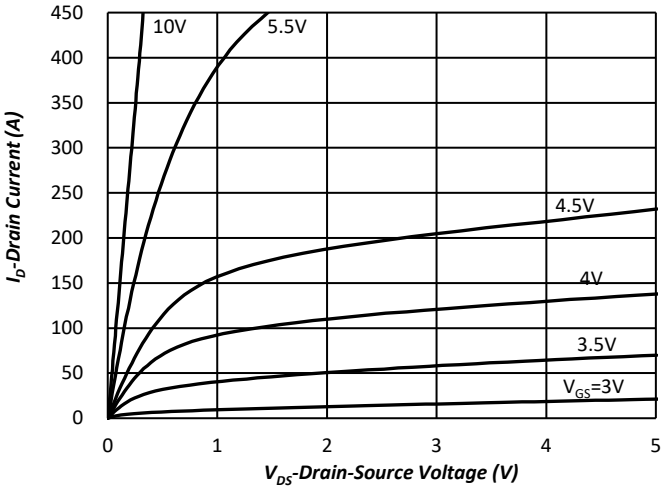


Fig.1 Typical Output Characteristics

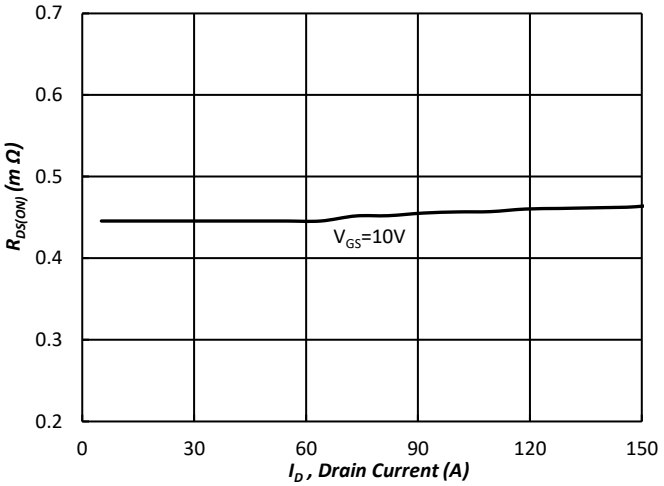


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

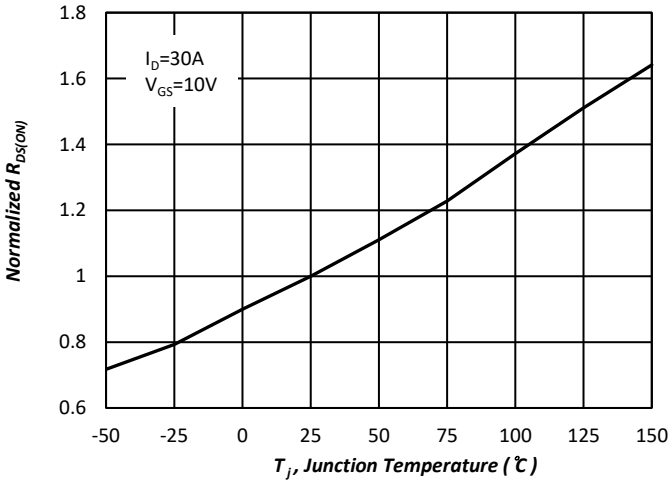


Fig.3 Normalized On-Resistance v.s. Junction Temperature

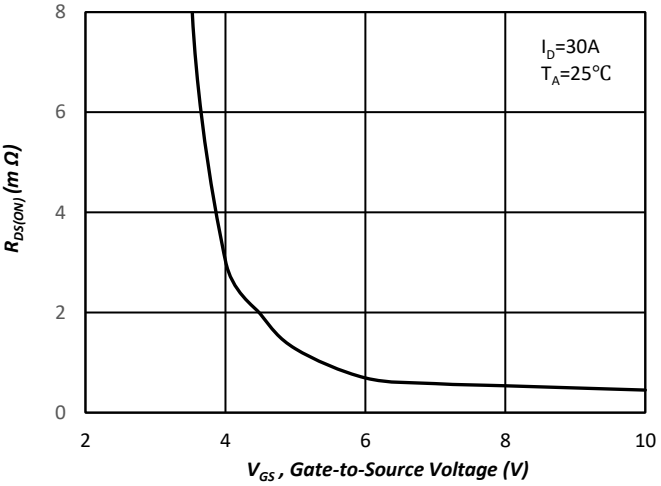


Fig.4 On-Resistance v.s. Gate Voltage

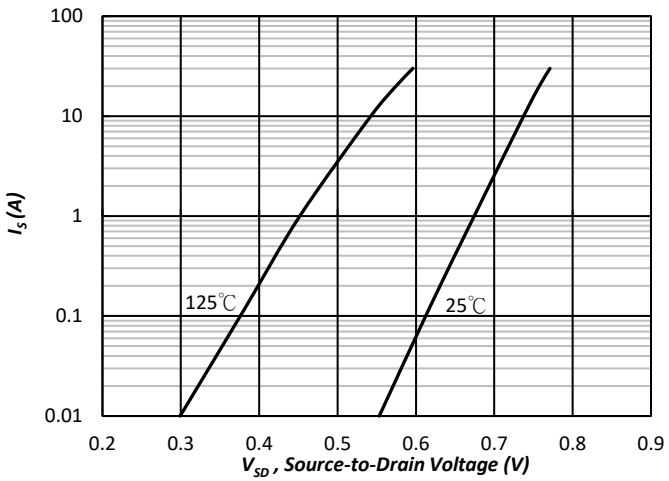


Fig.5 Forward Characteristic of Reverse Diode

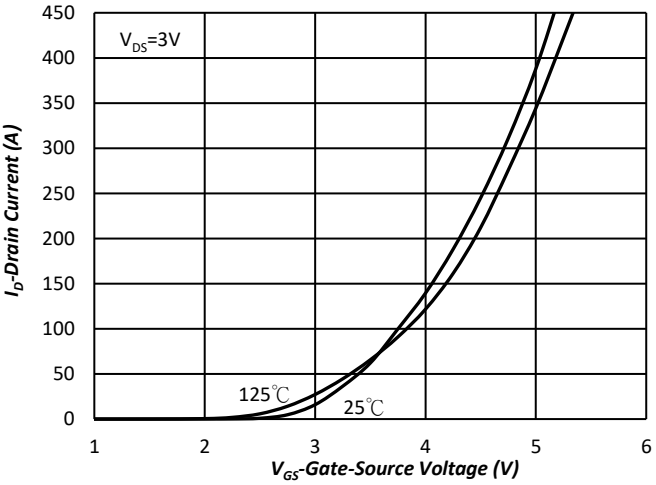


Fig.6 Transfer Characteristics

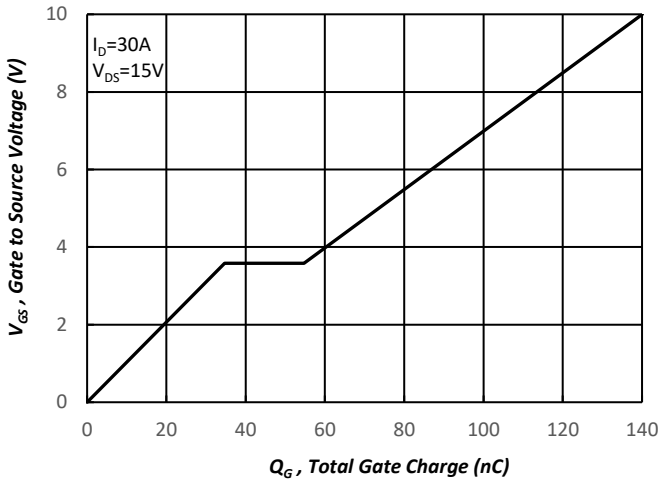


Fig.7 Gate Charge Characteristics

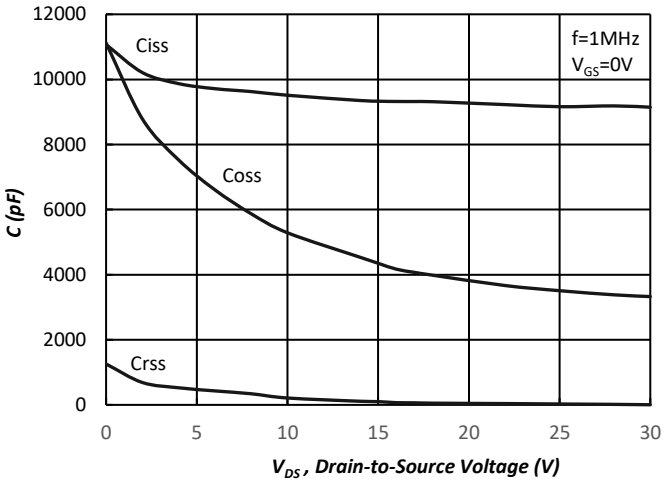


Fig.8 Typical Capacitance Characteristics

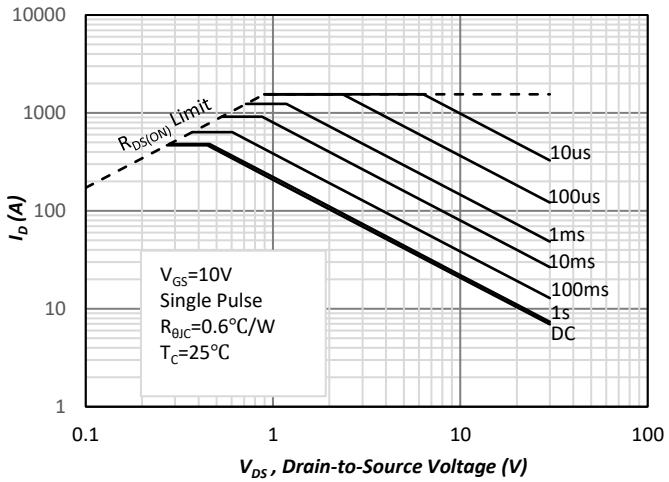


Fig 9. Maximum Safe Operating Area

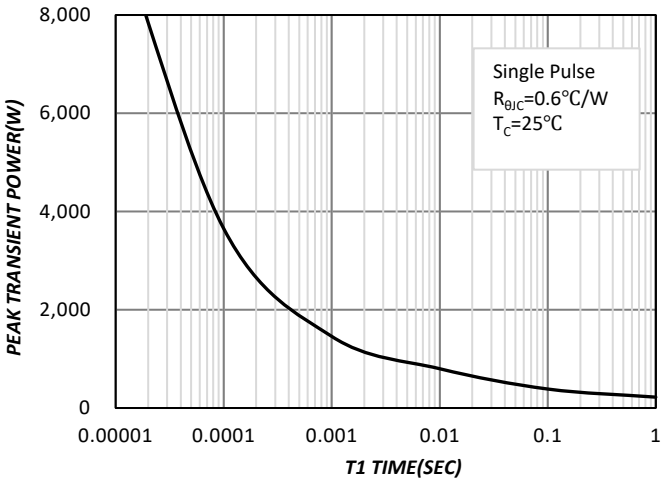


Fig 10. Single Pulse Maximum Power Dissipation

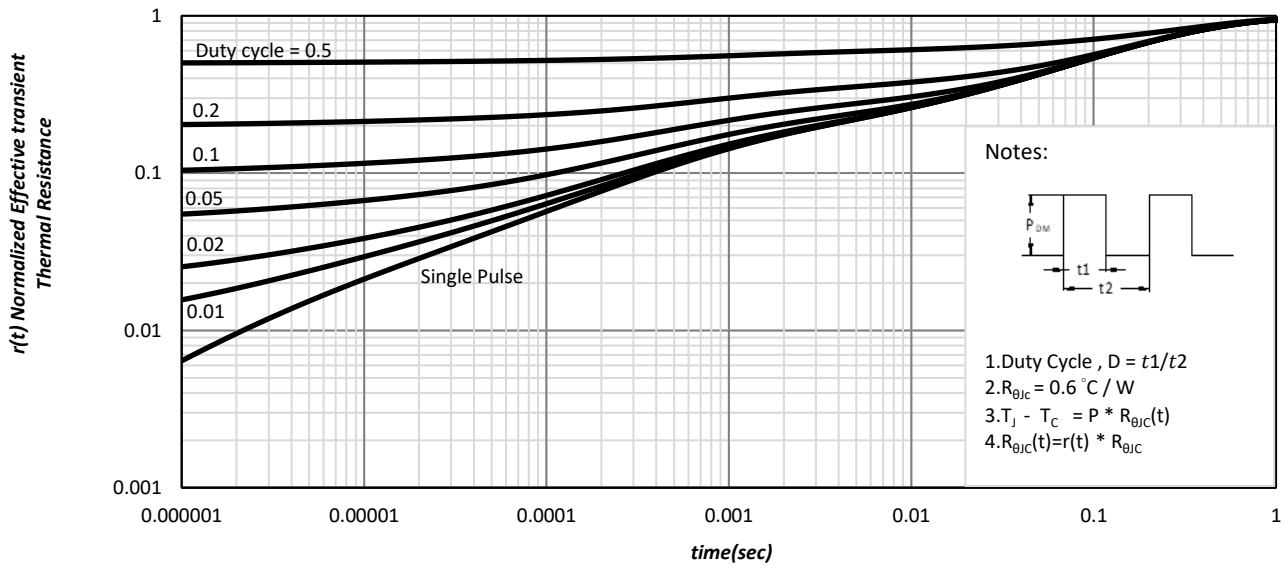
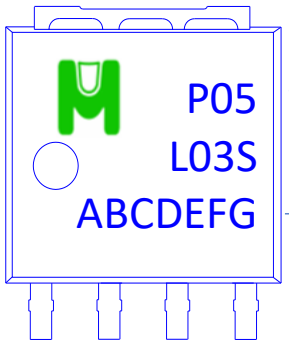


Fig 11. Effective Transient Thermal Impedance

Ordering & Marking Information:

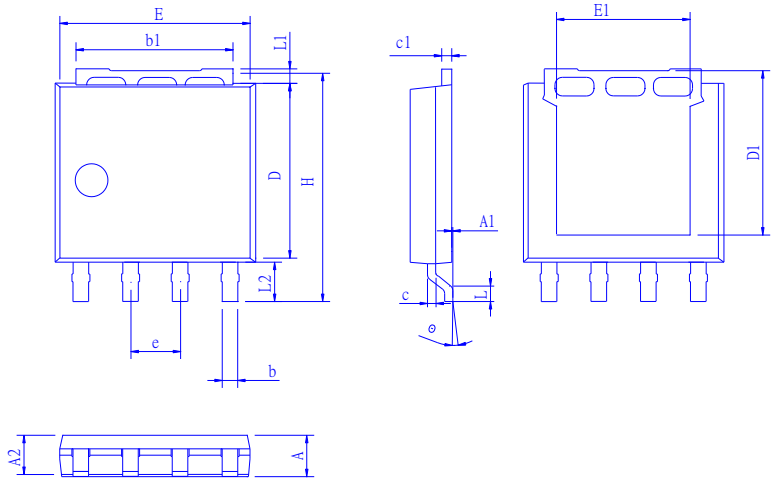
Device Name: EMP05L03RHCS for LFPAK5X6



P05L03S: Device Name

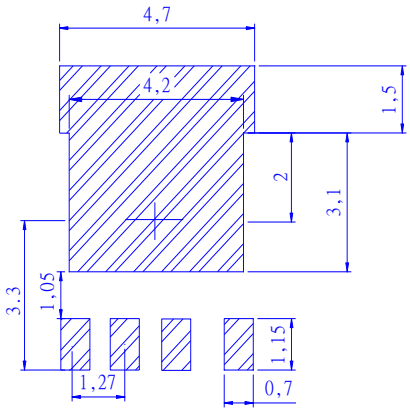
ABCDEFG: Date Code
A: Assembly House
B: Year(A:2008 B:2009 C:2010….)
C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
DEFG: Serial No.

Outline Drawing

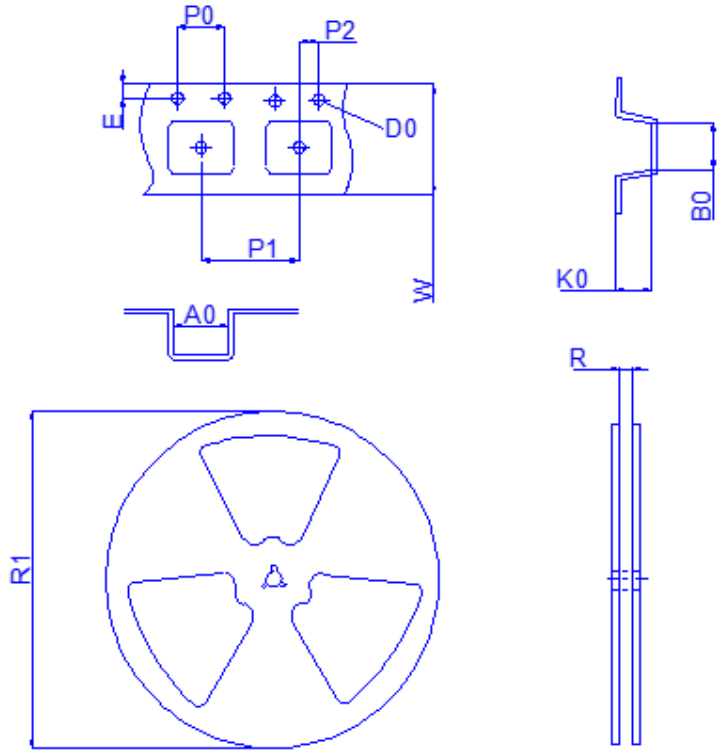


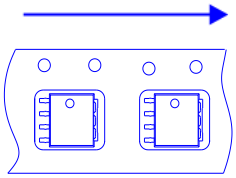
Dimension	A	A1	A2	b	b1	c	c1	D	D1	E	E1	e	H	L	L1	L2	Θ
Min	1.000	-	0.980	0.350	4.020	0.190	0.240	4.450	-	4.950	3.500	-	5.950	0.400	0.270	0.800	0°
Typ.	-	0.075	1.050	0.420	4.230	0.220	0.270		-	-	-	1.270	-	-	-		-
Max	1.300	0.150	1.120	0.500	4.410	0.250	0.300	4.700	4.450	5.300	3.700	-	6.250	0.850	0.570	1.300	8°

Footprint



◆ **Tape&Reel Information:2500pcs/Reel**



Package	LFPAK5X6
Reel	13”
Device orientation	FEED DIRECTION 

Dimension in mm

Dimension	Carrier tape									Reel	
	A0	B0	D0	E	K0	P0	P1	P2	W	R	R1
Typ.	6.58	5.50	1.50	1.75	1.45	4	8	2	12	12.4	330
±	0.10	0.10	0.10	0.10	0.10	0.05	0.05	0.05	0.3	2	2